Application/Control No. O9/854,979 Applicant(s)/Patent Under Reexamination LEKUCH ET AL Examiner Chanh Nguyen Applicant(s)/Patent Under Reexamination LEKUCH ET AL Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,430,526	02-1984	Brown et al.	345/175
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